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	OR.	AA	5,882,832	03/16/99	Tosaka et al.	-				
ı	a	AB	5,225,303	07/06/93	Tomita et al.	-				
		AC	5,168,028	12/01/92	Nanya et al.					
	COP.	AD	5,079,123	01/07/92	Nanya et al.	<				
	CIP	AE	5,102,766	04/07/92	Nanya et al.					
1	< X	AF	5,085,965	02/04/92	Nanya et al.					
ı	- OC	-AG	4,980,258	12/25/90	Aoki et al.					
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	T	Al	6,303,258	10/16/01	Katoh et al.					
ĺ	Qt-	AJ	6,183,926	02/06/01	Kuroda et al.	\ \				
	0/	AK	6,103,441	08/15/00	Tomita et al.					
	6	AL	6,074,794	06/13/00	Fushimi et al.					
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	OR	AN	5,879,849	03/09/99	Sawada et al.					
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	<u> </u>	- AP	63-184762	07/03/88	JAPAN w/English Abstract					
ı	Cr-	AQ	03-056974	03/12/91	JAPAN w/English Abstract					
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ı	C/R	AS	08-030017	02/02/96	JAPAN w/English Abstract					
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ı	OR	AU	09-211896	08/15/97	JAPAN w/English Abstract					
l	À	AV	11-218965	08/10/99	JAPAN w/English Abstract					
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COF	- AA	5,851,716	12/22/98	Kuramoto et al.				
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0)	AA	5,288,577	2-22-1994	Yamaguchi et al.				
OX-	AB	5,368,972	11-29-1994	Yamashita et al.				
COR	AC	5,429,901	7-4-1995	Muto et al.				
<9P-	AD	6,010,814	1-4-2000	Kotsugaii et al.				
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(n/-	AH	6,258,502	7-10-2001	Nakamura et al.	<			
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